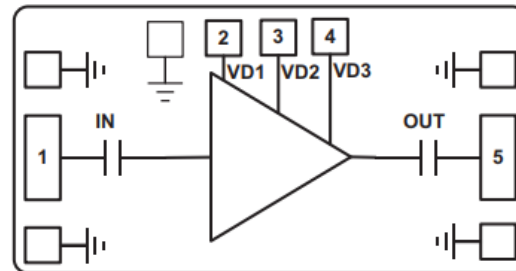


Features

- Noise Figure: 3.5dB
- Gain: 20dB
- P1dB: +8dBm
- Biasing +3V @ 38 mA
- Impedance: 50Ω
- Die Size: 2 x 1.3 x 0.1 mm

Typical Applications

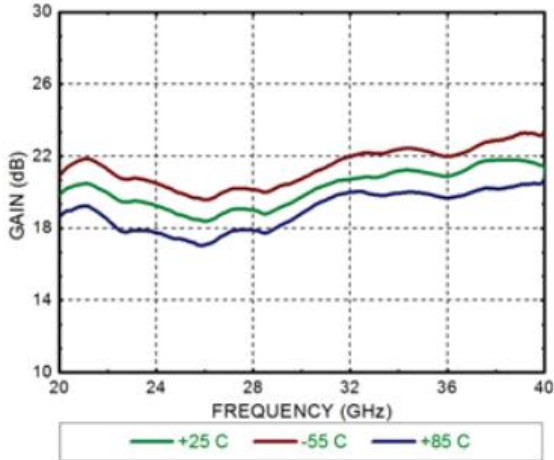
- Test Instrumentation
- Microwave Radio & VSAT
- Military & Space
- Telecom Infrastructure
- Fiber Optics

Functional Block Diagram

Electrical Specifications
TA = +25°C, Vdd = +3V Idd = 38mA

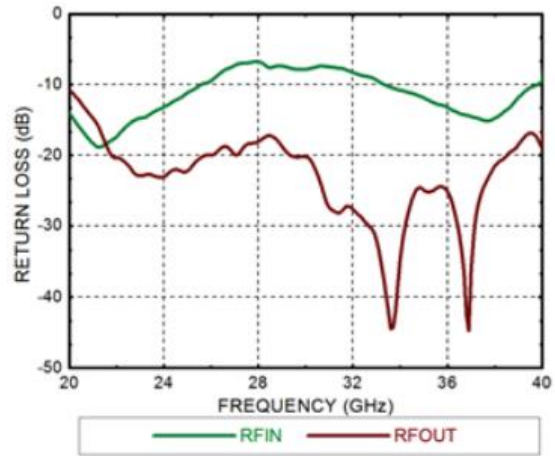
Parameters	Min.	Typ.	Max.	Min.	Typ.	Max.	Units
Frequency	20 - 30		30 - 40				GHz
Gain		19			21		dB
Gain Flatness		±1			±1		dB
Input Return Loss		10			10		dB
Output Return Loss		20			20		dB
Output 1dB Compression (P1dB)		8			8		dBm
Saturated Output Power (Psat)		10.5			10.5		dBm
Output Third Order Intercept (IP3)		19			19		dBm
Noise Figure		3.8			3.5		dB
Current	25	38	63	25	38	63	mA



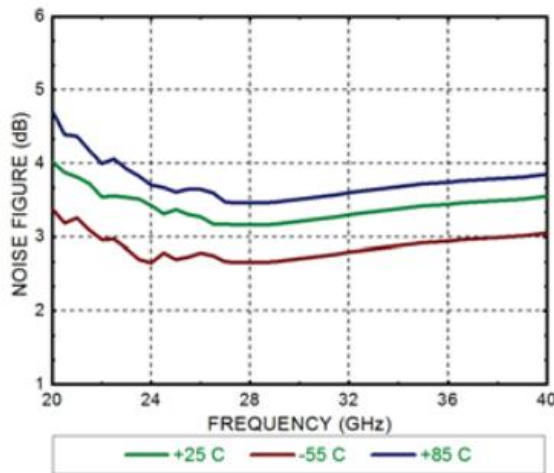
Gain



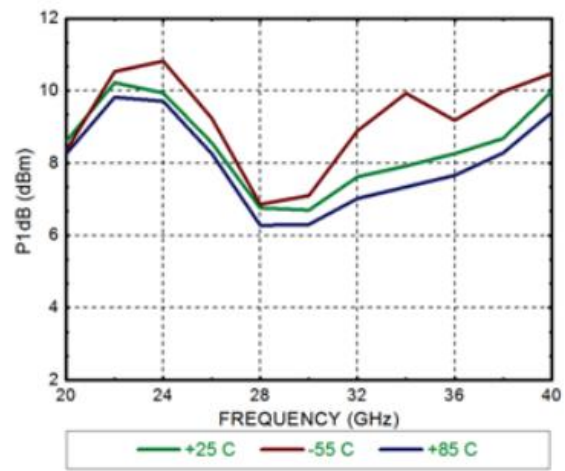
Return Loss



Noise Figure



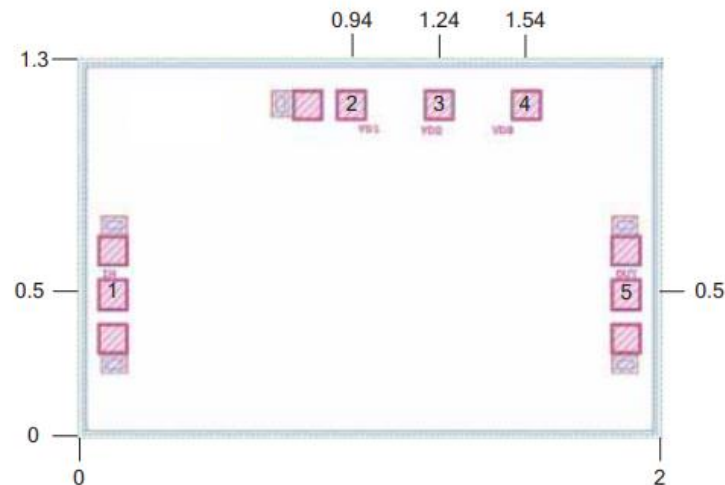
Output Power P_{1dB}





Outline Drawing:

All Dimensions in mm

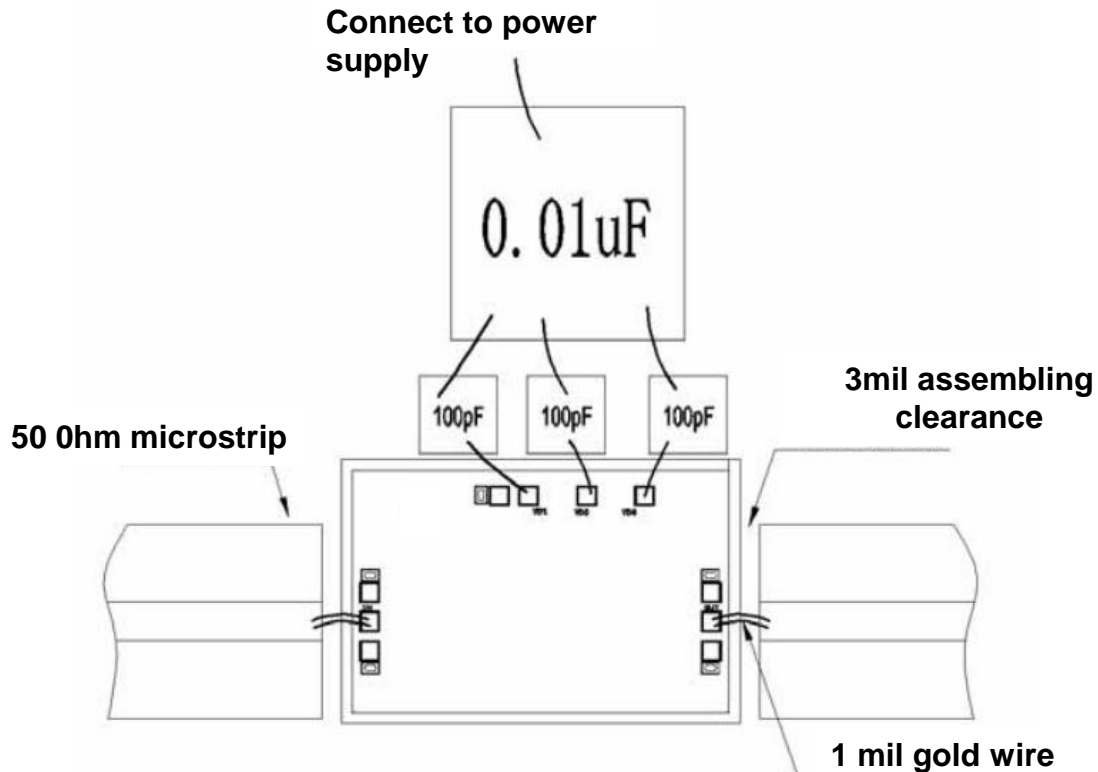


Pad Description

PAD	Function	Description
1	IN	Input AC coupling 50Ω Impedance
2, 3, 4	VD	This pad provides power supply voltage for the amplifier and requires external 100pF and 0.01uf bypass capacitor.
5	OUT	Output AC coupling 50Ω Impedance
Die Bottom	GND	Die bottom must be connected to RF/DC ground



Assembly Drawing



Notes:

1. Die thickness: 100um
2. Typical bond pad is 100*100 μm^2
3. Bond pad metalization: Gold
4. Backside metalization: Gold
5. Backside of the die (GND)
6. No connection required for unlabeled bond pads

Maximum Ratings:

1. Power supply voltage: +6V
2. RF input power: +16dBm
3. Storage temperature: -65°C to +175°C
4. Operating temperature: -55°C to +85°C